

N-Channel 30 V (D-S) MOSFET

	PRODUCT SUMMARY				
	V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)	
	30	$0.0149 \text{ at V}_{GS} = 10 \text{ V}$	20	15nC	
		0.019 at $V_{GS} = 4.5 \text{ V}$	16	13110	

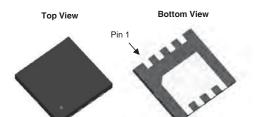
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

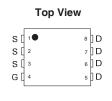


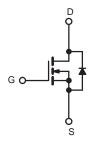
APPLICATIONS

- · Notebook PC Core
- VRM/POL



DFN 3x3 EP





N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	.,,	
Gate-Source Voltage	V _{GS}	± 20	V	
	T _C = 25 °C		20 ^{a, e}	
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		16 ^e	
Continuous Diain Current (1 _J = 175 °C)	T _A = 25 °C	I _D	15 ^{b, c}	A
	T _A = 70 °C		13 ^{b, c}	
Pulsed Drain Current		I _{DM}	60	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	17	
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	16	mJ
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	18 ^{a, e}	A
	T _A = 25 °C	18	13 ^{b, c}	
levimum Deuer Dissipation	T _C = 25 °C		16	
	T _C = 70 °C	P _D	7	W
Maximum Power Dissipation	T _A = 25 °C	' D	4.5 ^{b, c}	VV
	T _A = 70 °C		2.6 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS	ERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	31	44	°C/W		
Maximum Junction-to-Case	Steady State	R _{thJC}	3	4	5/77		

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 s.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature.



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	$I_D = 250 \mu\text{A}$		- 5.5		mv/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zono Coto Valto no Duniu Comunit	I _{DSS}	V _{DS} = 24 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current		$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	10		10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	60			Α	
		V _{GS} = 10 V, I _D = 10 A		0.0149	0.017	_	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.019	0.022	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 24 V, I _D = 10 A		35		S	
Dynamic ^b							
Input Capacitance	C _{iss}			655		pF	
Output Capacitance	C _{oss}	V _{DS} = 24V, V _{GS} = 0 V, f = 1 MHz		422			
Reverse Transfer Capacitance	C _{rss}			109			
Total Octo Observe	Qg	V _{DS} = 24 V, V _{GS} = 10 V, I _D = 10 A		14			
Total Gate Charge				6.6			
Gate-Source Charge	Source Charge Q _{gs}			4		nC	
Gate-Drain Charge	Q _{gd}			3		1	
Gate Resistance	R _g	f = 1 MHz		3		Ω	
Turn-On Delay Time	t _{d(on)}			11		ns	
Rise Time	t _r	$V_{DD} = 24 \text{ V}, R_L = 1.8 \Omega$		9			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 3 \Omega$		25			
Fall Time	t _f			12			
Turn-On Delay Time	t _{d(on)}			20			
Rise Time	t _r	$V_{DD} = 24 \text{ V}, R_L = 1.8 \Omega$		17			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 8 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 3 \Omega$		50			
Fall Time	t _f			18			
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			18	_	
Pulse Diode Forward Current ^a	I _{SM}				54	A	
Body Diode Voltage	V _{SD}	I _S = 10 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			10		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 10 A di/dt 100 A/ T 05 00		15		nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		20		ns	
Reverse Recovery Rise Time	t _b			22			

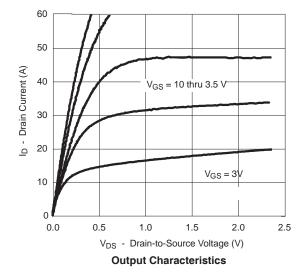
Notes:

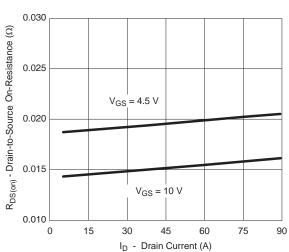
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

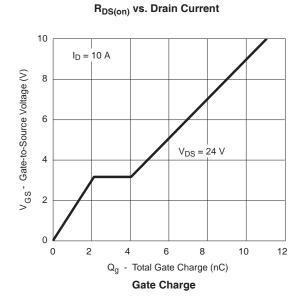
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

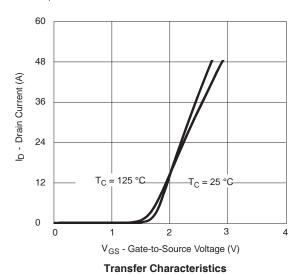


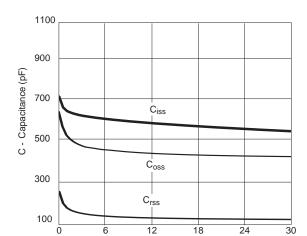
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



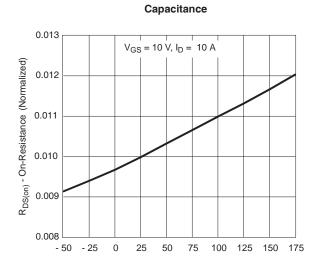








 $V_{\mbox{\footnotesize DS}}$ - Drain-to-Source Voltage (V)

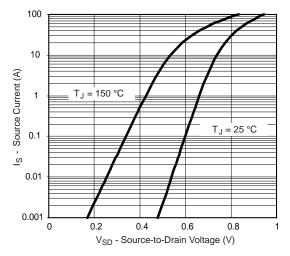


On-Resistance vs. Junction Temperature

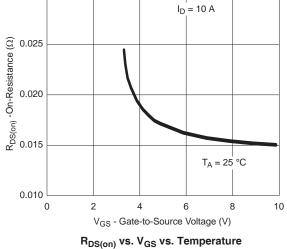




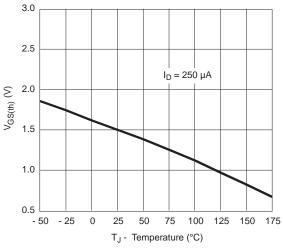
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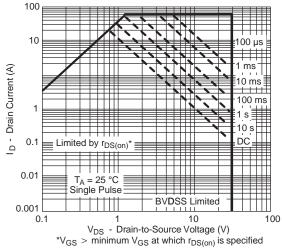
Forward Diode Voltage vs. Temperature



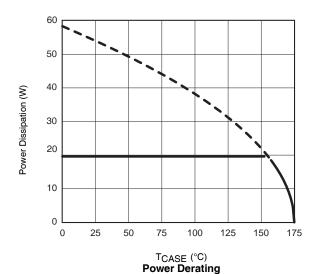
0.030



Threshold Voltage

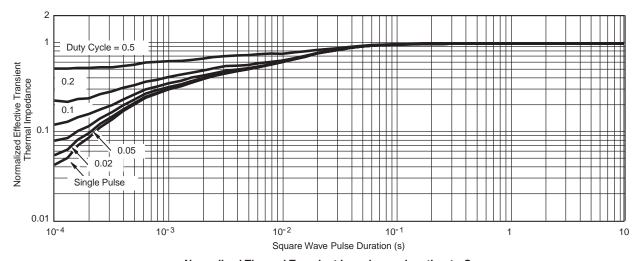


Safe Operating Area, Junction-to-Ambient



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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case





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